

<i>Notice of References Cited</i>	Application/Control No. 10/560,023	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Erin Snelting	Art Unit 1791	Page 1 of 1

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*	C US-6,616,873	09-2003	Duraiswami et al.	264/44
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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